

# **OptiMOS**<sup>®</sup>3 Power-Transistor

#### **Features**

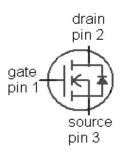
- N-channel, normal level
- Excellent gate charge x R DS(on) product (FOM)
- Very low on-resistance R<sub>DS(on)</sub>
- 175 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target application
- Ideal for high-frequency switching and synchronous rectification

#### **Product Summary**

V <sub>DS</sub>	150	V
R <sub>DS(on),max (TO263)</sub>	7.2	mΩ
I <sub>D</sub>	100	Α



Туре	IPB072N15N3 G	IPP075N15N3 G	IPI075N15N3 G
	1 3 (tab)	123	123
Package	PG-TO263-3	PG-TO220-3	PG-TO262-3
Marking	072N15N	075N15N	075N15N



#### **Maximum ratings,** at $T_i$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	T <sub>C</sub> =25 °C	100	Α
		T <sub>C</sub> =100 °C	93	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	400	
Avalanche energy, single pulse	E <sub>AS</sub>	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 $\Omega$	780	mJ
Reverse diode dv/dt	dv/dt	$I_{D}$ =100 A, $V_{DS}$ =120 V, d <i>i</i> /d <i>t</i> =100 A/ $\mu$ s, $T_{j,max}$ =175 °C	6	kV/μs
Gate source voltage	$V_{GS}$		±20	V
Power dissipation	P tot	T <sub>C</sub> =25 °C	300	W
Operating and storage temperature	$T_{\rm j}$ , $T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

<sup>1)</sup>J-STD20 and JESD22

<sup>&</sup>lt;sup>2)</sup> See figure 3



# IPB072N15N3 G IPP075N15N3 G

IP	107	5N1	5N	3 G

Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	$R_{ m thJC}$		-	-	0.5	K/W
Thermal resistance, junction -	$R_{ m thJA}$	minimal footprint	-	-	62	
ambient		6 cm2 cooling area <sup>3)</sup>	-	-	40	

# **Electrical characteristics,** at $T_{\rm j}$ =25 °C, unless otherwise specified

#### **Static characteristics**

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	150	-	-	V
Gate threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 270 \mu A$	2	3	4	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =120 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	-	0.1	1	μΑ
		V <sub>DS</sub> =120 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	-	10	100	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	1	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10 V, I <sub>D</sub> =100 A, (TO220, TO262)	-	6.2	7.5	mΩ
		V <sub>GS</sub> =10 V, I <sub>D</sub> =100 A, (TO263)	-	5.8	7.2	
		V <sub>GS</sub> =8 V, I <sub>D</sub> =50 A, (TO220; TO262)	-	6.4	7.7	
		V <sub>GS</sub> =8 V, I <sub>D</sub> =50 A, (TO263)	-	6.0	7.4	
Gate resistance	R <sub>G</sub>		1	2.3	-	Ω
Transconductance	g fs	V <sub>DS</sub>  >2 I <sub>D</sub>  R <sub>DS(on)max</sub> , I <sub>D</sub> =100 A	65	130	-	s

 $<sup>^{3)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



# IPB072N15N3 G IPP075N15N3 G

# IPI075N15N3 G

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss		-	5470	-	pF
Output capacitance	C oss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =75 V, f=1 MHz	-	638	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	10	-	
Turn-on delay time	t <sub>d(on)</sub>		-	25	38	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =75 V, V <sub>GS</sub> =10 V,	-	35	52	
Turn-off delay time	$t_{\text{d(off)}}$	$I_{\rm D}$ =100 A, $R_{\rm G}$ =1.6 Ω	-	46	69	
Fall time	t <sub>f</sub>	]	-	14	21	
Gate Charge Characteristics <sup>4)</sup>		T		I	Γ	
Gate to source charge	Q <sub>gs</sub>		-	30	40	nC
Gate to drain charge	$Q_{gd}$		-	11	17	
Switching charge	$Q_{sw}$	V <sub>DD</sub> =75 V, I <sub>D</sub> =100 A, V <sub>GS</sub> =0 to 10 V	-	25	35	
Gate charge total	Q <sub>g</sub>		-	70	93	
Gate plateau voltage	$V_{ m plateau}$		-	5.5	-	٧
Output charge	Q oss	V <sub>DD</sub> =75 V, V <sub>GS</sub> =0 V	-	179	239	nC
Reverse Diode						
Diode continous forward current	Is	- T <sub>C</sub> =25 °C	-	-	100	Α
Diode pulse current	I <sub>S,pulse</sub>	7 c-25 C	-	-	400	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, I <sub>F</sub> =100 A, T <sub>j</sub> =25 °C	-	1	1.2	V
Reverse recovery time	t rr	V <sub>R</sub> =75 V, I <sub>F</sub> =I <sub>S</sub> ,	-	146	-	ns
Reverse recovery charge	Q <sub>rr</sub>	d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/µs	-	478	-	nC

<sup>&</sup>lt;sup>4)</sup> See figure 16 for gate charge parameter definition



# 1 Power dissipation

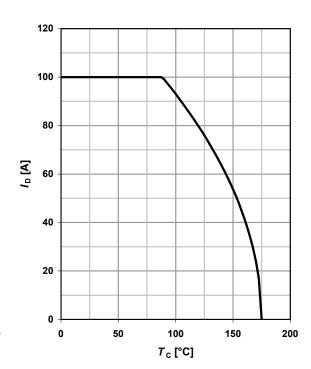
# $P_{\text{tot}}$ =f( $T_{\text{C}}$ )

# 280 240 200 100 120 80 40 0 0 0 50 100 150 200

 $T_{\rm C}$  [°C]

#### 2 Drain current

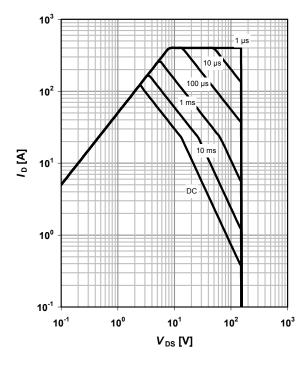
$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$



# 3 Safe operating area

$$I_D = f(V_{DS}); T_C = 25 \,^{\circ}C; D = 0$$

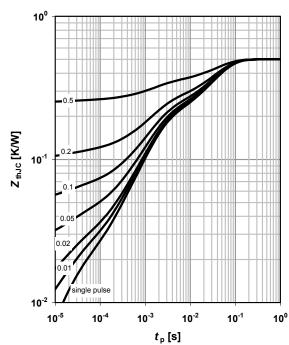
parameter:  $t_{\rm p}$ 



# 4 Max. transient thermal impedance

$$Z_{\text{thJC}}$$
=f( $t_{p}$ )

parameter:  $D = t_p/T$ 

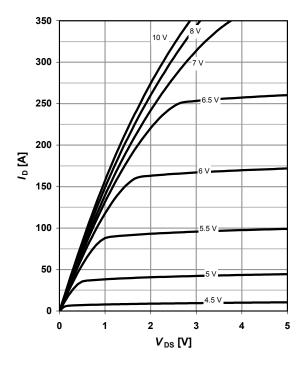




#### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$ 

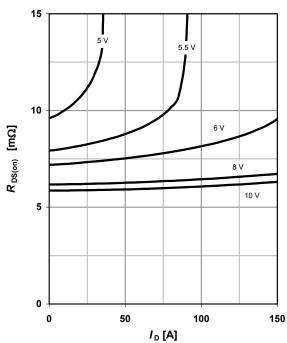
parameter:  $V_{\rm GS}$ 



#### 6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f( $I_D$ );  $T_j$ =25 °C

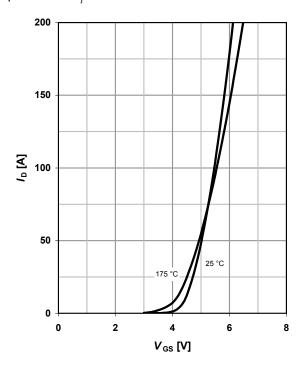
parameter:  $V_{\rm GS}$ 



# 7 Typ. transfer characteristics

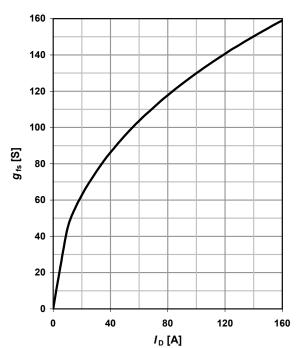
 $I_{D}$ =f( $V_{GS}$ );  $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$ 

parameter:  $T_{\rm j}$ 



# 8 Typ. forward transconductance

 $g_{fs}$ =f( $I_D$ );  $T_j$ =25 °C





#### 9 Drain-source on-state resistance

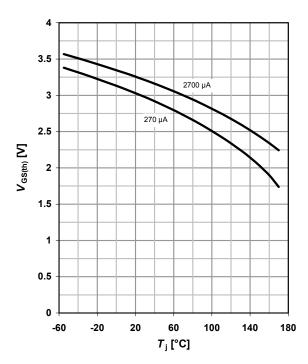
$$R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$$

# 20 15 10 98% 5 0 -60 -20 20 60 100 140 180 $T_j$ [°C]

# 10 Typ. gate threshold voltage

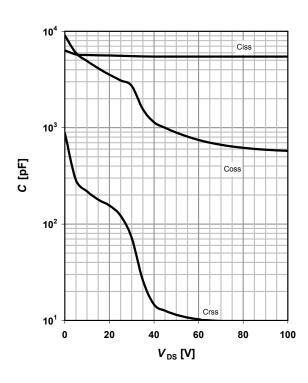
$$V_{GS(th)}$$
=f( $T_j$ );  $V_{GS}$ = $V_{DS}$ 

parameter:  $I_D$ 



# 11 Typ. capacitances

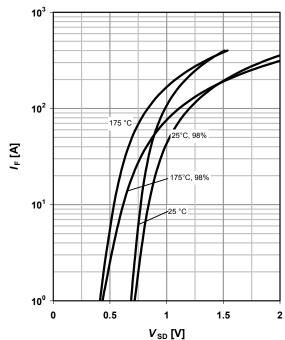
$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$



#### 12 Forward characteristics of reverse diode

$$I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$$

parameter:  $T_{\rm j}$ 





#### 13 Avalanche characteristics

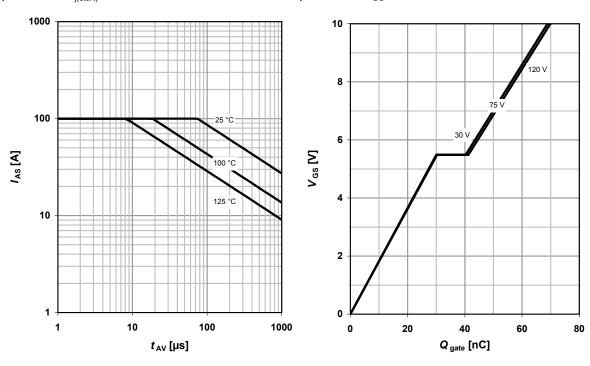
 $I_{AS}$ =f( $t_{AV}$ );  $R_{GS}$ =25  $\Omega$ 

parameter:  $T_{j(start)}$ 

# 14 Typ. gate charge

 $V_{\rm GS}$ =f(Q <sub>gate</sub>);  $I_{\rm D}$ =100 A pulsed

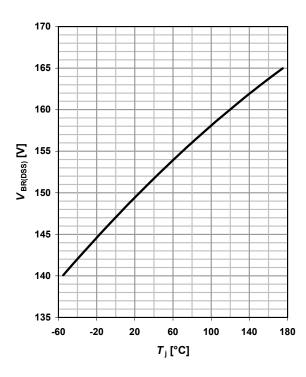
parameter:  $V_{\rm DD}$ 

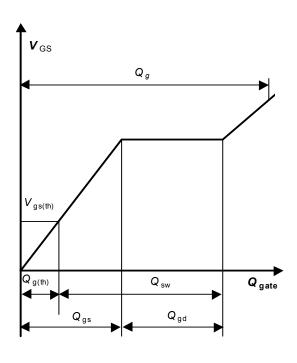


# 15 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_i); I_D=1 \text{ mA}$ 

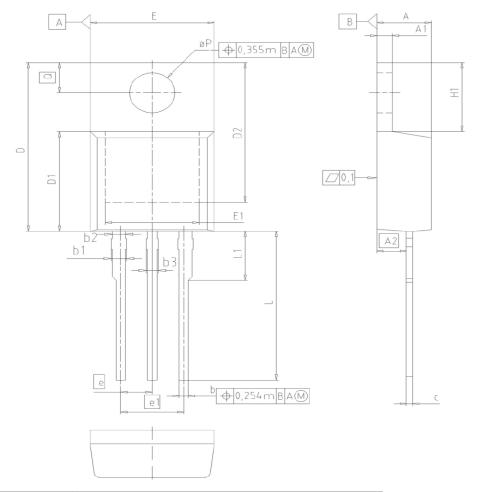
# 16 Gate charge waveforms



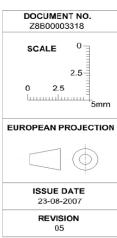




#### PG-TO220-3: Outline

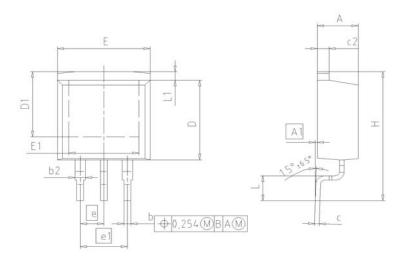


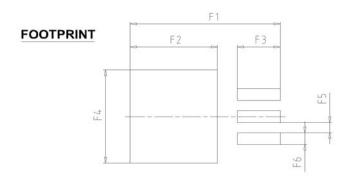
DIM	MILLI	MILLIMETERS		HES
DIW	MIN	MAX	MIN	MAX
Α	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
b	0.65	0.86	0.026	0.034
b1	0.95	1.40	0.037	0.055
b2	0.95	1.15	0.037	0.045
b3	0.65	1.15	0.026	0.045
С	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0.335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6.50	8.60	0.256	0.339
е	2.54		0.1	100
e1	5	5.08		200
N		3	;	3
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
øΡ	3.60	3.89	0.142	0.153
Q	2.60	3.00	0.102	0.118





#### PG-TO263-3: Outline



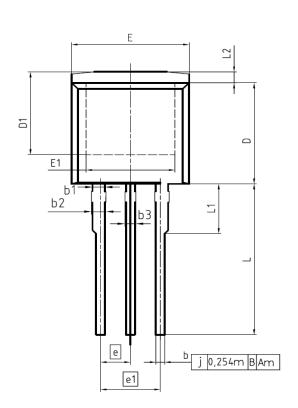


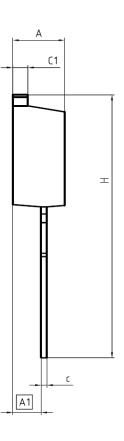
DIM	MILLIN	IETERS	INC	HES
ым	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	0.00	0.25	0.000	0.010
b	0.65	0.85	0.026	0.033
b2	0.95	1.15	0.037	0.045
С	0.33	0.65	0.013	0.026
c2	1.17	1.40	0.046	0.055
D	8.51	9.45	0.335	0.372
D1	7.10	7.90	0.280	0.311
E	9.80	10.31	0.386	0.406
E1	6.50	8.60	0.256	0.339
е	2.54		0.1	100
e1	5.0	08	0.2	200
N		3		3
н	14.61	15.88	0.575	0.625
L	2.29	3.00	0.090	0.118
L1	0.70	1.60	0.028	0.063
F1	16.05	16.25	0.632	0.640
F2	9.30	9.50	0.366	0.374
F3	4.50	4.70	0.177	0.185
F4	10.70	10.90	0.421	0.429
F5	1.10	1.30	0.043	0.051
F6	1.25	1.45	0.049	0.057

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#### PG-TO262-3: Outline





DIM	MILLIM	ETERS	INCH	IES
I DIM	MIN	MAX	MIN	MAX
Α	4,300	4,572	0.169	0.180
A1	2,150	2,718	0.085	0.107
Ь	0.650	0.864	0.026	0.034
b1	0.950	1.093	0.037	0.043
b2	0.950	1,400	0.037	0,055
b3	0.650	1.118	0.026	0.044
С	0.330	0.600	0.013	0.024
c1	1.170	1.400	0.046	0.055
D	8,509	9,450	0,335	0,372
D1	6.900	-	0.272	-
E	9.700	10.363	0.382	0.408
E1	6.500	8.600	0.256	0.339
е	2,5	540	0,1	00
e1	5.080		0.200	
N		3	3	3
L	13.000	14.000	0.512	0.551
L1	-	4,800	-	0.189
L2	-	1.727	-	0.068

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FILE TO262_1	



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